

**NT2GC72B89B0NF / NT4GC72B8PB0NF
 NT2GC72C89B0NF / NT4GC72C8PB0NF
 2GB: 256M x 72 / 4GB: 512M x 72
 PC3-8500 / PC3-10600
 Unbuffered DDR3 SDRAM DIMM with ECC**



Based on DDR3-1066/1333 256Mx8 SDRAM B-Die

Features

• Performance:

Speed Sort	PC3-8500	PC3-10600	Unit
	-BE	-CG	
DIMM CAS Latency	7	9	
fck – Clock Frequency	533	667	MHz
tck – Clock Cycle	1.875	1.5	ns
fDQ – DQ Burst Frequency	1066	1333	Mbps

- 240-Pin Dual In-Line Memory Module (UDIMM)
- 256Mx72 and 512Mx72 DDR3 Unbuffered DIMM with ECC based on 256Mx8 DDR3 SDRAM B-Die devices.
- Intended for 533MHz/667MHz applications
- $V_{DD} = V_{DDQ} = 1.5V \pm 0.075V$ (for DDR3)
- $V_{DD} = V_{DDQ} = 1.35V+0.0675/-0.1V$ (for DDR3L)
- SDRAMs have 8 internal banks for concurrent operation
- Differential clock inputs
- Data is read or written on both clock edges
- DRAM DLL aligns DQ and DQS transitions with clock transitions.
- Address and control signals are fully synchronous to positive clock edge
- Nominal and Dynamic On-Die Termination support
- Halogen free product

- Programmable Operation:
 - DIMM $\overline{\text{CAS}}$ Latency: 6,7,8,9
 - Burst Type: Sequential or Interleave
 - Burst Length: BC4, BL8
 - Operation: Burst Read and Write
- Two different termination values (Rtt_Nom & Rtt_WR)
- 15/10/1 (row/column/rank) Addressing for 2GB
- 15/10/2 (row/column/rank) Addressing for 4GB
- Extended operating temperature range
- Auto Self-Refresh option
- Serial Presence Detect
- Gold contacts
- SDRAMs are in 78-ball BGA Package
- RoHS compliance

Description

NT2GC72C89B0NF and NT4GC72C8PC0NF are 240-Pin Double Data Rate 3 (DDR3) Synchronous DRAM Unbuffered Dual In-Line Memory Module with ECC (UDIMM w/ ECC), organized as one rank of 256Mx72 (2GB) and two ranks of 512Mx72 (4GB) high-speed memory array. Modules use nine 256Mx8 (2GB) 78-ball BGA packaged devices and eighteen 256Mx8 (4GB) 78-ball BGA packaged devices. These DIMMs are manufactured using raw cards developed for broad industry use as reference designs. The use of these common design files minimizes electrical variation between suppliers. All NANYA DDR3 SDRAM DIMMs provide a high-performance, flexible 8-byte interface in a 5.25" long space-saving footprint.

The DIMM is intended for use in applications operating of 533MHz/667MHz clock speeds and achieves high-speed data transfer rates of 1066Mbps/1333Mbps. Prior to any access operation, the device $\overline{\text{CAS}}$ latency and burst/length/operation type must be programmed into the DIMM by address inputs A0-A14 and I/O inputs BA0–BA2 using the mode register set cycle.

The DIMM uses serial presence-detect implemented via a serial EEPROM using a standard IIC protocol. The first 128 bytes of SPD data are programmed and locked during module assembly. The remaining 128 bytes are available for use by the customer.

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Ordering Information

Part Number	Speed			Organization	Power	Leads	Note
NT2GC72B89B0NF-BE	DDR3-1066	PC3-8500	533MHz (1.875ns @ CL = 7)	256Mx72	1.5V	Gold	
NT2GC72B89B0NF-CG	DDR3-1333	PC3-10600	667MHz (1.5ns @ CL = 9)				
NT4GC72B8PB0NF-BE	DDR3-1066	PC3-8500	533MHz (1.875ns @ CL = 7)	512Mx72	1.35V	Gold	
NT4GC72B8PB0NF-CG	DDR3-1333	PC3-10600	667MHz (1.5ns @ CL = 9)				
NT2GC72C89B0NF-BE	DDR3-1066	PC3-8500	533MHz (1.875ns @ CL = 7)	256Mx72	1.35V	Gold	
NT2GC72C89B0NF-CG	DDR3-1333	PC3-10600	667MHz (1.5ns @ CL = 9)				
NT4GC72C8PB0NF-BE	DDR3-1066	PC3-8500	533MHz (1.875ns @ CL = 7)	512Mx72	1.35V	Gold	
NT4GC72C8PB0NF-CG	DDR3-1333	PC3-10600	667MHz (1.5ns @ CL = 9)				

Pin Description

Pin Name	Description	Pin Name	Description
CK0, CK1	Clock Inputs, positive line	DQ0-DQ63	Data input/output
CK̄0, CK̄1	Clock Inputs, negative line	DQS0-DQS8	Data strobes
CKE0, CKE1	Clock Enable	DQS̄0-DQS8̄	Data strobes complement
RAS	Row Address Strobe	DM0-DM8	Data Masks
CAS	Column Address Strobe	CB0-CB7	ECC Check Bits
WE	Write Enable	EVENT	Temperature event pin
S0, S1	Chip Selects	RESET	Reset pin
A0-A9, A11, A13	Address Inputs	V _{REFDQ} , V _{REFCA}	Input/Output Reference
A10/AP	Address Input/Auto-Precharge	V _{DDSPD}	SPD and Temp sensor power
A12/B̄C	Address Input/Burst Chop	SA0, SA1	Serial Presence Detect Address Inputs
BA0-BA2	SDRAM Bank Address Inputs	V _{tt}	Termination voltage
ODT0, ODT1	Active termination control lines	V _{ss}	Ground
SCL	Serial Presence Detect Clock Input	V _{dd}	Core and I/O power
SDA	Serial Presence Detect Data input/output	NC	No Connect

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DDR3 SDRAM Pin Assignment

Pin	Front	Pin	Back	Pin	Front	Pin	Back	Pin	Front	Pin	Back	Pin	Front	Pin	Back
1	V _{REFDQ}	121	V _{SS}	31	DQ25	151	V _{SS}	61	A2	181	A1	91	DQ41	211	V _{SS}
2	V _{SS}	122	DQ4	32	V _{SS}	152	DM3	62	V _{DD}	182	V _{DD}	92	V _{SS}	212	DM5
3	DQ0	123	DQ5	33	<u>DQS3</u>	153	NC	63	CK1/NC	183	V _{DD}	93	<u>DQS5</u>	213	NC
4	DQ1	124	V _{SS}	34	DQS3	154	V _{SS}	64	<u>CK1</u> /NC	184	CK0	94	DQS5	214	V _{SS}
5	V _{SS}	125	DM0	35	V _{SS}	155	DQ30	65	V _{DD}	185	<u>CK0</u>	95	V _{SS}	215	DQ46
6	<u>DQS0</u>	126	NC	36	DQ26	156	DQ31	66	V _{DD}	186	V _{DD}	96	DQ42	216	DQ47
7	DQS0	127	V _{SS}	37	DQ27	157	V _{SS}	67	V _{REFCA}	187	<u>EVENT</u>	97	DQ43	217	V _{SS}
8	V _{SS}	128	DQ6	38	V _{SS}	158	CB4	68	NC	188	A0	98	V _{SS}	218	DQ52
9	DQ2	129	DQ7	39	CB0	159	CB5	69	V _{DD}	189	V _{DD}	99	DQ48	219	DQ53
10	DQ3	130	V _{SS}	40	CB1	160	V _{SS}	70	A10/AP	190	BA1	100	DQ49	220	V _{SS}
11	V _{SS}	131	DQ12	41	V _{SS}	161	DM8	71	BA0	191	V _{DD}	101	V _{SS}	221	DM6
12	DQ8	132	DQ13	42	<u>DQS8</u>	162	NC	72	V _{DD}	192	<u>RAS</u>	102	<u>DQS6</u>	222	NC
13	DQ9	133	V _{SS}	43	DQS8	163	V _{SS}	73	<u>WE</u>	193	<u>S0</u>	103	DQS6	223	V _{SS}
14	V _{SS}	134	DM1	44	V _{SS}	164	CB6	74	<u>CAS</u>	194	V _{DD}	104	V _{SS}	224	DQ54
15	<u>DQS1</u>	135	NC	45	CB2	165	CB7	75	V _{DD}	195	ODT0	105	DQ50	225	DQ55
16	DQS1	136	V _{SS}	46	CB3	166	V _{SS}	76	<u>S1/NC</u>	196	A13	106	DQ51	226	V _{SS}
17	V _{SS}	137	DQ14	47	V _{SS}	167	NC	77	ODT1/NC	197	V _{DD}	107	V _{SS}	227	DQ60
18	DQ10	138	DQ15	48	NC	168	<u>RESET</u>	78	V _{DD}	198	NC	108	DQ56	228	DQ61
19	DQ11	139	V _{SS}	49	NC	169	CKE1/NC	79	NC	199	V _{SS}	109	DQ57	229	V _{SS}
20	V _{SS}	140	DQ20	50	CKE0	170	V _{DD}	80	V _{SS}	200	DQ36	110	V _{SS}	230	DM7
21	DQ16	141	DQ21	51	V _{DD}	171	NC	81	DQ32	201	DQ37	111	<u>DQS7</u>	231	NC
22	DQ17	142	V _{SS}	52	BA2	172	NC	82	DQ33	202	V _{SS}	112	DQS7	232	V _{SS}
23	V _{SS}	143	DM2	53	NC	173	V _{DD}	83	V _{SS}	203	DM4	113	V _{SS}	233	DQ62
24	<u>DQS2</u>	144	NC	54	V _{DD}	174	A12/ <u>BC</u>	84	DQS4	204	NC	114	DQ58	234	DQ63
25	DQS2	145	V _{SS}	55	A11	175	A9	85	DQS4	205	V _{SS}	115	DQ59	235	V _{SS}
26	V _{SS}	146	DQ22	56	A7	176	V _{DD}	86	V _{SS}	206	DQ38	116	V _{SS}	236	V _{DDSPD}
27	DQ18	147	DQ23	57	V _{DD}	177	A8	87	DQ34	207	DQ39	117	SA0	237	SA1
28	DQ19	148	V _{SS}	58	A5	178	A6	88	DQ35	208	V _{SS}	118	SCL	238	SDA
29	V _{SS}	149	DQ28	59	A4	179	V _{DD}	89	V _{SS}	209	DQ44	119	SA2	239	V _{SS}
30	DQ24	150	DQ29	60	V _{DD}	180	A3	90	DQ40	210	DQ45	120	V _{TT}	240	V _{TT}

Note: CK1, CK1, CKE1, S1 and ODT1 are for 2GB modules only.

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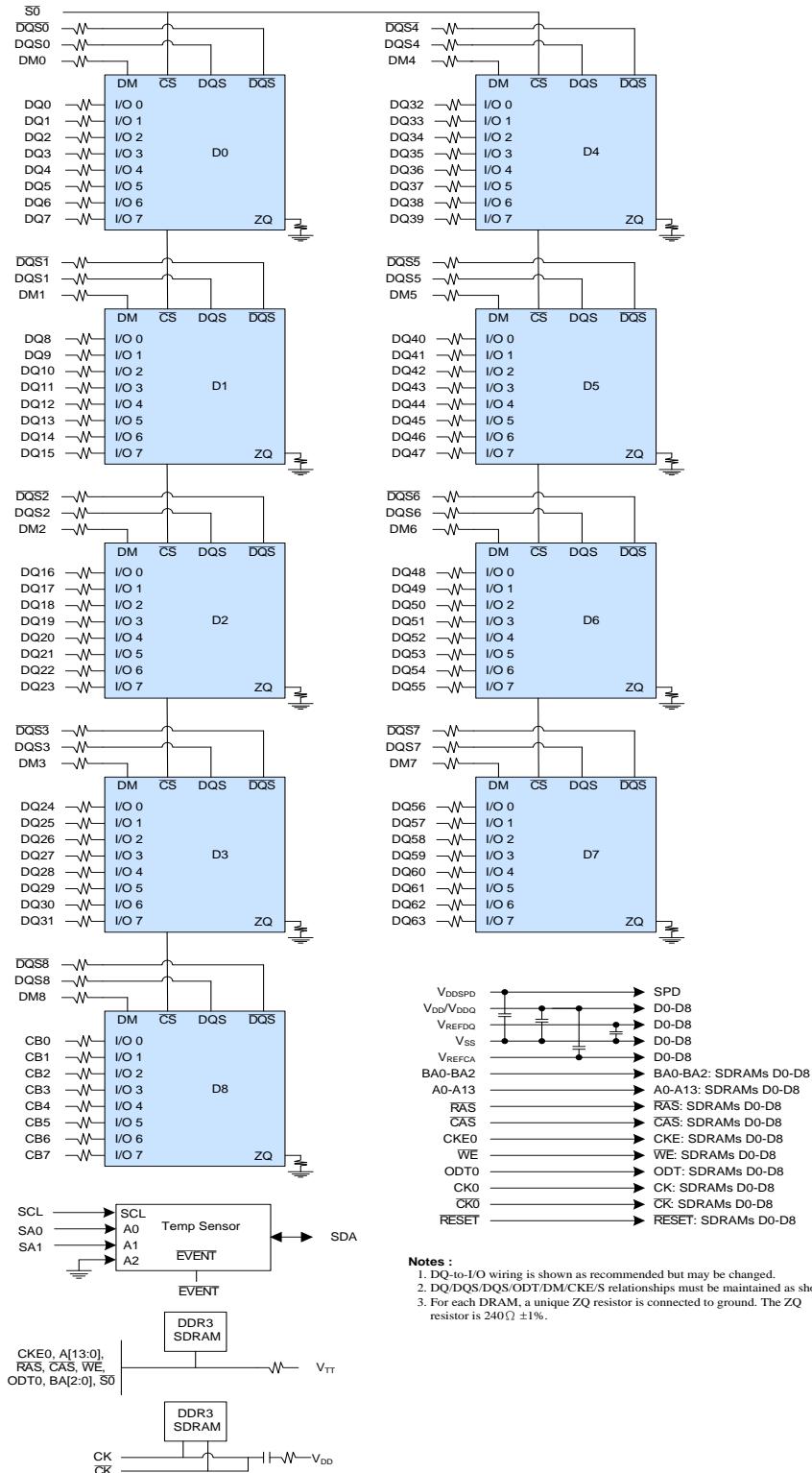


Input/Output Functional Description

Symbol	Type	Polarity	Function
\overline{CK}_0, CK_1 \overline{CK}_0, CK_1	Input	Cross point	The system clock inputs. All address and command lines are sampled on the cross point of the rising edge of CK and falling edge of \overline{CK} . A Delay Locked Loop (DLL) circuit is driven from the clock inputs and output timing for read operations is synchronized to the input clock.
CKE0, CKE1	Input	Active High	Activates the DDR3 SDRAM CK signal when high and deactivates the CK signal when low. By deactivating the clocks, CKE low initiates the Power Down mode or the Self Refresh mode.
$\overline{S0}, S1$	Input	Active Low	Enables the associated DDR3 SDRAM command decoder when low and disables the command decoder when high. When the command decoder is disabled, new commands are ignored but previous operations continue. Rank 0 is selected by $\overline{S0}$; Rank 1 is selected by $S1$.
$\overline{RAS}, \overline{CAS}, \overline{WE}$	Input	Active Low	When sampled at the positive rising edge of CK and falling edge of \overline{CK} , signals \overline{RAS} , \overline{CAS} , \overline{WE} define the operation to be executed by the SDRAM.
ODT0, ODT1	Input	Active High	Asserts on-die termination for DQ, DM, DQS, and \overline{DQS} signals if enabled via the DDR3 SDRAM mode register.
DM0 – DM8	Input	Active High	The data write masks, associated with one data byte. In Write mode, DM operates as a byte mask by allowing input data to be written if it is low but blocks the write operation if it is high. In Read mode, DM lines have no effect.
DQS0 – DQS8 $\overline{DQS}_0 - \overline{DQS}_8$	I/O	Cross point	The data strobes, associated with one data byte, sourced with data transfers. In Write mode, the data strobe is sourced by the controller and is centered in the data window. In Read mode, the data strobe is sourced by the DDR3 SDRAM and is sent at the leading edge of the data window. \overline{DQS} signals are complements, and timing is relative to the cross point of respective DQS and \overline{DQS} . If the module is to be operated in single ended strobe mode, all \overline{DQS} signals must be tied on the system board to V_{ss} and DDR3 SDRAM mode registers programmed appropriately.
BA0, BA1, BA2	Input	-	Selects which DDR3 SDRAM internal bank of four or eight is activated.
A0 – A9 A10/AP A11 A12/ \overline{BC} A13	Input	-	During a Bank Activate command cycle, defines the row address when sampled at the cross point of the rising edge of CK and falling edge of \overline{CK} . During a Read or Write command cycle, defines the column address when sampled at the cross point of the rising edge of CK and falling edge of \overline{CK} . In addition to the column address, AP is used to invoke autoprecharge operation at the end of the burst read or write cycle. If AP is high, autoprecharge is selected and BA0-BAn defines the bank to be precharged. If AP is low, autoprecharge is disabled. During a Precharge command cycle, AP is used in conjunction with BA0-BAn to control which bank(s) to precharge. If AP is high, all banks will be precharged regardless of the state of BA0-BAn inputs. If AP is low, then BA0-BAn are used to define which bank to precharge.
DQ0 – DQ63	Input	-	Data Input/Output pins.
CB0 – CB7	I/O		Check bits are used for ECC
V_{DD} , V_{DDSPD} , V_{SS}	Supply	-	Power supplies for core, I/O, Serial Presence Detect, Temp sensor, and ground for the module.
V_{REFDQ} , V_{REFCA}	Supply	-	Reference voltage for SSTL15 inputs
SDA	I/O	-	This is a bidirectional pin used to transfer data into or out of the SPD EEPROM and temp sensor. A resistor must be connected from the SDA bus line to V_{DDSPD} on the system planar to act as a pull up.
SCL	Input	-	This signal is used to clock data into and out of the SPD EEPROM and Temp sensor.
SA0 – SA2	Input	-	Address pins used to select the Serial Presence Detect and Temp sensor base address.
\overline{EVENT}	Output	-	The \overline{EVENT} pin is reserved for use to flag critical module temperature.
RESET	Input	-	This signal resets the DDR3 SDRAM

Functional Block Diagram

[2GB – 1 Rank, 256Mx8 DDR3 SDRAMs]

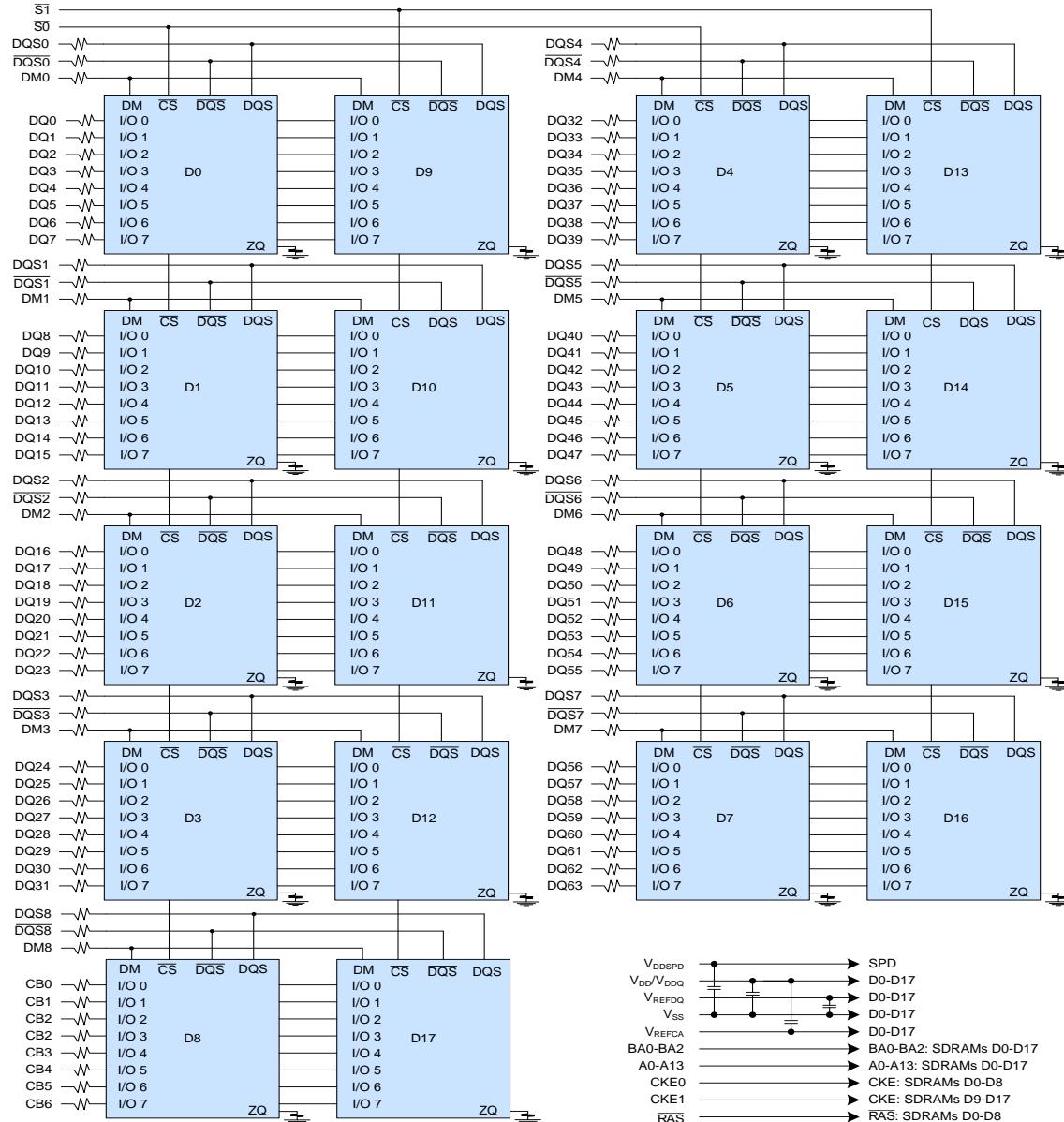


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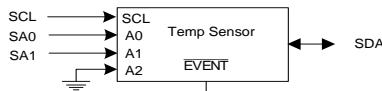
Functional Block Diagram

[4GB – 2 Ranks, 256Mx8 DDR3 SDRAMs]



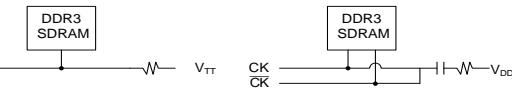
Notes :

1. DQ-to-I/O wiring is shown as recommended but may be changed.
2. DQ/DQS/DQS/ODT/DM/CKE/S relationships must be maintained as shown.
3. For each DRAM, a unique ZQ resistor is connected to ground. The ZQ resistor is 240Ω ±1%.



CKE[1:0], A[13:0],
 RAS, CAS, WE,
 ODT[1:0], BA[2:0],
 S[1:0]

V _{DDSPD}	SPD
V _{DD} /V _{DQDQ}	D0-D17
V _{REFDQ}	D0-D17
V _{SS}	D0-D17
V _{REFCA}	D0-D17
BA0-BA2	BA0-BA2: SDRAMs D0-D17
A0-A13	A0-A13: SDRAMs D0-D17
CKE0	CKE: SDRAMs D0-D8
CKE1	CKE: SDRAMs D9-D17
RAS	RAS: SDRAMs D0-D8
CAS	CAS: SDRAMs D0-D8
WE	WE: SDRAMs D0-D8
ODT0	ODT: SDRAMs D0-D8
ODT1	ODT: SDRAMs D9-D17
CK0	CK: SDRAMs D0-D8
CK1	CK: SDRAMs D0-D8
CK2	CK: SDRAMs D9-D17
CK3	CK: SDRAMs D9-D17
CK4	CK: SDRAMs D9-D17
CK5	CK: SDRAMs D9-D17
CK6	CK: SDRAMs D9-D17
CK7	CK: SDRAMs D9-D17
CK8	CK: SDRAMs D9-D17
CK9	CK: SDRAMs D9-D17
CK10	CK: SDRAMs D9-D17
CK11	CK: SDRAMs D9-D17
CK12	CK: SDRAMs D9-D17
CK13	CK: SDRAMs D9-D17
CK14	CK: SDRAMs D9-D17
CK15	CK: SDRAMs D9-D17
CK16	CK: SDRAMs D9-D17
CK17	CK: SDRAMs D9-D17
CK18	CK: SDRAMs D9-D17
CK19	CK: SDRAMs D9-D17
CK20	CK: SDRAMs D9-D17
CK21	CK: SDRAMs D9-D17
CK22	CK: SDRAMs D9-D17
CK23	CK: SDRAMs D9-D17
CK24	CK: SDRAMs D9-D17
CK25	CK: SDRAMs D9-D17
CK26	CK: SDRAMs D9-D17
CK27	CK: SDRAMs D9-D17
CK28	CK: SDRAMs D9-D17
CK29	CK: SDRAMs D9-D17
CK30	CK: SDRAMs D9-D17
CK31	CK: SDRAMs D9-D17
CK32	CK: SDRAMs D9-D17
CK33	CK: SDRAMs D9-D17
CK34	CK: SDRAMs D9-D17
CK35	CK: SDRAMs D9-D17
CK36	CK: SDRAMs D9-D17
CK37	CK: SDRAMs D9-D17
CK38	CK: SDRAMs D9-D17
CK39	CK: SDRAMs D9-D17
CK40	CK: SDRAMs D9-D17
CK41	CK: SDRAMs D9-D17
CK42	CK: SDRAMs D9-D17
CK43	CK: SDRAMs D9-D17
CK44	CK: SDRAMs D9-D17
CK45	CK: SDRAMs D9-D17
CK46	CK: SDRAMs D9-D17
CK47	CK: SDRAMs D9-D17
CK48	CK: SDRAMs D9-D17
CK49	CK: SDRAMs D9-D17
CK50	CK: SDRAMs D9-D17
CK51	CK: SDRAMs D9-D17
CK52	CK: SDRAMs D9-D17
CK53	CK: SDRAMs D9-D17
CK54	CK: SDRAMs D9-D17
CK55	CK: SDRAMs D9-D17
CK56	CK: SDRAMs D9-D17
CK57	CK: SDRAMs D9-D17
CK58	CK: SDRAMs D9-D17
CK59	CK: SDRAMs D9-D17
CK60	CK: SDRAMs D9-D17
CK61	CK: SDRAMs D9-D17
CK62	CK: SDRAMs D9-D17
CK63	CK: SDRAMs D9-D17



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Serial Presence Detect [NT2GC72B89B0NF, 2GB – 1 Rank, 256Mx8 DDR3 SDRAMs]

Byte	Description	Serial PD Data Entry (Hex.)	
		-BE	-CG
0	CRC range, EEPROM bytes, bytes used	92	92
1	SPD revision	10	10
2	DRAM device type	0B	0B
3	Module type (form factor)	02	02
4	SDRAM Device density and banks	03	03
5	SDRAM device row and column count	19	19
6	Module minimum nominal voltage	00	00
7	Module ranks and device DQ count	01	01
8	ECC tag and module memory Bus width	0B	0B
9	Fine timebase dividend/divisor (in ps)	52	52
10	Medium timebase dividend	01	01
11	Medium timebase divisor	08	08
12	Minimum SDRAM cycle time (tCKmin)	0F	0C
13	Reserved	00	00
14	CAS latencies supported	1C	3C
15	CAS latencies supported	00	00
16	Minimum CAS latency time (tAAmin)	69	69
17	Minimum write recovery time (tWRmin)	78	78
18	Minimum CAS-to-CAS delay (tRCDmin)	69	69
19	Minimum Row Active to Row Active delay (tRRDmin)	3C	30
20	Minimum row Precharge delay (tRPmin)	69	69
21	Upper nibble for tRAS and tRC	11	11
22	Minimum Active-to-Precharge delay (tRASmin)	2C	20
23	Minimum Active-to-Active/Refresh delay (tRCmin)	95	89
24	Minimum refresh recovery delay (tRFCmin) LSB	00	00
25	Minimum refresh recovery delay (tRFCmin) MSB	05	05
26	Minimum internal Write-to-Read command delay (tWTRmin)	3C	3C
27	Minimum internal Read-to-Precharge command delay (tRTPmin)	3C	3C
28	Minimum four active window delay (tFAWmin) LSB	01	00
29	Minimum four active window delay (tFAWmin) MSB	2C	F0
30	SDRAM device output drivers supported	83	83
31	SDRAM device thermal and refresh options	05	05
32	Module Thermal Sensor	80	80
33	SDRAM Device Type	00	00
60	Module height (nominal)	0F	0F
61	Module thickness (Max)	01	01
62	Raw Card ID reference	03	03
63	DRAM address mapping edge connector	00	00
117	Module manufacture ID	83	83
118	Module manufacture ID	0B	0B
119-121	Module manufacturer Information	--	--
126	CRC	87	C5
127	CRC	A8	01
128-145	Module part number	--	--
146	Module die revision	--	--
147	Module PCB revision	--	--
150-175	Manufacturer reserved	--	--
176-255	Customer reserved	--	--

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Byte	Description	Serial PD Data Entry (Hex.)	
		-BE	-CG
0	CRC range, EEPROM bytes, bytes used	92	92
1	SPD revision	10	10
2	DRAM device type	0B	0B
3	Module type (form factor)	02	02
4	SDRAM Device density and banks	03	03
5	SDRAM device row and column count	19	19
6	Module minimum nominal voltage	02	02
7	Module ranks and device DQ count	01	01
8	ECC tag and module memory Bus width	0B	0B
9	Fine timebase dividend/divisor (in ps)	52	52
10	Medium timebase dividend	01	01
11	Medium timebase divisor	08	08
12	Minimum SDRAM cycle time (tCKmin)	0F	0C
13	Reserved	00	00
14	CAS latencies supported	1C	3C
15	CAS latencies supported	00	00
16	Minimum CAS latency time (tAAMin)	69	69
17	Minimum write recovery time (tWRmin)	78	78
18	Minimum CAS-to-CAS delay (tRCDmin)	69	69
19	Minimum Row Active to Row Active delay (tRRDmin)	3C	30
20	Minimum row Precharge delay (tRPmin)	69	69
21	Upper nibble for tRAS and tRC	11	11
22	Minimum Active-to-Precharge delay (tRASmin)	2C	20
23	Minimum Active-to-Active/Refresh delay (tRCmin)	95	89
24	Minimum refresh recovery delay (tRFCmin) LSB	00	00
25	Minimum refresh recovery delay (tRFCmin) MSB	05	05
26	Minimum internal Write-to-Read command delay (tWTRmin)	3C	3C
27	Minimum internal Read-to-Precharge command delay (tRTPmin)	3C	3C
28	Minimum four active window delay (tFAWmin) LSB	01	00
29	Minimum four active window delay (tFAWmin) MSB	2C	F0
30	SDRAM device output drivers supported	83	83
31	SDRAM device thermal and refresh options	05	05
32	Module Thermal Sensor	80	80
33	SDRAM Device Type	00	00
60	Module height (nominal)	0F	0F
61	Module thickness (Max)	01	01
62	Raw Card ID reference	03	03
63	DRAM address mapping edge connector	00	00
117	Module manufacturer ID	83	83
118	Module manufacturer ID	0B	0B
119-121	Module manufacturer Information	--	--
126	CRC	2C	6E
127	CRC	2F	86
128-145	Module part number	--	--
146	Module die revision	--	--
147	Module PCB revision	--	--
150-175	Manufacturer reserved	--	--
176-255	Customer reserved	--	--

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2GB: 256M x 72 / 4GB: 512M x 72
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Serial Presence Detect [NT4GC72B8PB0NF, 4GB – 2 Rank, 256Mx8 DDR3 SDRAMs]

Byte	Description	Serial PD Data Entry (Hex.)	
		-BE	-CG
0	CRC range, EEPROM bytes, bytes used	92	92
1	SPD revision	10	10
2	DRAM device type	0B	0B
3	Module type (form factor)	02	02
4	SDRAM Device density and banks	03	03
5	SDRAM device row and column count	19	19
6	Module minimum nominal voltage	00	00
7	Module ranks and device DQ count	09	09
8	ECC tag and module memory Bus width	0B	0B
9	Fine timebase dividend/divisor (in ps)	52	52
10	Medium timebase dividend	01	01
11	Medium timebase divisor	08	08
12	Minimum SDRAM cycle time (tCKmin)	0F	0C
13	Reserved	00	00
14	CAS latencies supported	1C	3C
15	CAS latencies supported	00	00
16	Minimum CAS latency time (tAAMin)	69	69
17	Minimum write recovery time (tWRmin)	78	78
18	Minimum CAS-to-CAS delay (tRCDmin)	69	69
19	Minimum Row Active to Row Active delay (tRRDmin)	3C	30
20	Minimum row Precharge delay (tRPmin)	69	69
21	Upper nibble for tRAS and tRC	11	11
22	Minimum Active-to-Precharge delay (tRASmin)	2C	20
23	Minimum Active-to-Active/Refresh delay (tRCmin)	95	89
24	Minimum refresh recovery delay (tRFCmin) LSB	00	00
25	Minimum refresh recovery delay (tRFCmin) MSB	05	05
26	Minimum internal Write-to-Read command delay (tWTRmin)	3C	3C
27	Minimum internal Read-to-Precharge command delay (tRTPmin)	3C	3C
28	Minimum four active window delay (tFAWmin) LSB	01	00
29	Minimum four active window delay (tFAWmin) MSB	2C	F0
30	SDRAM device output drivers supported	83	83
31	SDRAM device thermal and refresh options	05	05
32	Module Thermal Sensor	80	80
33	SDRAM Device Type	00	00
60	Module height (nominal)	0F	0F
61	Module thickness (Max)	11	11
62	Raw Card ID reference	04	04
63	DRAM address mapping edge connector	01	01
117	Module manufacture ID	83	83
118	Module manufacture ID	0B	0B
119-121	Module manufacturer Information	--	--
126	CRC	44	06
127	CRC	BF	16
128-145	Module part number	--	--
146	Module die revision	--	--
147	Module PCB revision	--	--
150-175	Manufacturer reserved	--	--
176-255	Customer reserved	--	--

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Serial Presence Detect [NT4GC72C8PB0NF, 4GB – 2 Rank, 256Mx8 DDR3 SDRAMs]

Byte	Description	Serial PD Data Entry (Hex.)	
		-BE	-CG
0	CRC range, EEPROM bytes, bytes used	92	92
1	SPD revision	10	10
2	DRAM device type	0B	0B
3	Module type (form factor)	02	02
4	SDRAM Device density and banks	03	03
5	SDRAM device row and column count	19	19
6	Module minimum nominal voltage	02	02
7	Module ranks and device DQ count	09	09
8	ECC tag and module memory Bus width	0B	0B
9	Fine timebase dividend/divisor (in ps)	52	52
10	Medium timebase dividend	01	01
11	Medium timebase divisor	08	08
12	Minimum SDRAM cycle time (tCKmin)	0F	0C
13	Reserved	00	00
14	CAS latencies supported	1C	3C
15	CAS latencies supported	00	00
16	Minimum CAS latency time (tAAMin)	69	69
17	Minimum write recovery time (tWRmin)	78	78
18	Minimum CAS-to-CAS delay (tRCDmin)	69	69
19	Minimum Row Active to Row Active delay (tRRDmin)	3C	30
20	Minimum row Precharge delay (tRPmin)	69	69
21	Upper nibble for tRAS and tRC	11	11
22	Minimum Active-to-Precharge delay (tRASmin)	2C	20
23	Minimum Active-to-Active/Refresh delay (tRCmin)	95	89
24	Minimum refresh recovery delay (tRFCmin) LSB	00	00
25	Minimum refresh recovery delay (tRFCmin) MSB	05	05
26	Minimum internal Write-to-Read command delay (tWTRmin)	3C	3C
27	Minimum internal Read-to-Precharge command delay (tRTPmin)	3C	3C
28	Minimum four active window delay (tFAWmin) LSB	01	00
29	Minimum four active window delay (tFAWmin) MSB	2C	F0
30	SDRAM device output drivers supported	83	83
31	SDRAM device thermal and refresh options	05	05
32	Module Thermal Sensor	80	80
33	SDRAM Device Type	00	00
60	Module height (nominal)	0F	0F
61	Module thickness (Max)	11	11
62	Raw Card ID reference	04	04
63	DRAM address mapping edge connector	01	01
117	Module manufacture ID	83	83
118	Module manufacture ID	0B	0B
119-121	Module manufacturer Information	--	--
126	CRC	EF	AD
127	CRC	38	91
128-145	Module part number	--	--
146	Module die revision	--	--
147	Module PCB revision	--	--
150-175	Manufacturer reserved	--	--
176-255	Customer reserved	--	--

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Environmental Requirements

Symbol	Parameter	Rating	Units	Note
T _{OPR}	Module Operating Temperature Range (ambient)	0 to 55	°C	3
H _{OPR}	Operating Humidity (relative)	10 to 90	%	1
T _{STG}	Storage Temperature (Plastic)	-55 to 100	°C	1
H _{STG}	Storage Humidity (without condensation)	5 to 95	%	1
P _{BAR}	Barometric Pressure (operating & storage)	105 to 69	K Pascal	1, 2

Note:

1. Stresses greater than those listed may cause permanent damage to the device. This is a stress rating only and device functional operation at or above the conditions indicated is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
2. Up to 9850 ft.
3. The component maximum case temperature shall not exceed the value specified in the component spec.

Absolute Maximum DC Ratings

Symbol	Parameter	Rating	Units	Note
V _{DD}	Voltage on VDD pins relative to Vss	-0.4 V ~ 1.975 V	V	1, 3
V _{DDQ}	Voltage on VDDQ pins relative to Vss	-0.4 V ~ 1.975 V	V	1, 3
V _{IN} , V _{OUT}	Voltage on I/O pins relative to Vss	-0.4 V ~ 1.975 V	V	1
T _{STG}	Storage Temperature	-55 to +100	°C	1, 2

Note:

1. Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability
2. Storage Temperature is the case surface temperature on the center/top side of the DRAM. For the measurement conditions, please refer to JESD51-2 standard.
3. VDD and VDDQ must be within 300 mV of each other at all times; and VREF must be not greater

Operating temperature Conditions

Symbol	Parameter	Rating	Units	Note
T _{OPER}	Normal Operating Temperature Range	0 to 85	°C	1, 2
	Extended Temperature Range	85 to 95	°C	1, 3

Note:

1. Operating Temperature TOPER is the case surface temperature on the center / top side of the DRAM. For measurement conditions, please refer to the JEDEC document JESD51-2.
2. The Normal Temperature Range specifies the temperatures where all DRAM specifications will be supported. During operation, the DRAM case temperature must be maintained between 0 to 85 °C under all operating conditions
3. Some applications require operation of the DRAM in the Extended Temperature Range between 85 °C and 95 °C case temperature. Full specifications are supported in this range, but the following additional conditions apply:
 - a) Refresh commands must be doubled in frequency, therefore reducing the Refresh interval tREFI to 3.9 µs. It is also possible to specify a component with 1X refresh (tREFI to 7.8µs) in the Extended Temperature Range. Please refer to supplier data sheet and/or the DIMM SPD for option availability.
 - b) If Self-Refresh operation is required in the Extended Temperature Range, then it is mandatory to either use the Manual Self-Refresh mode with Extended Temperature Range capability (MR2 A6 = 0b and MR2 A7 = 1b) or enable the optional Auto Self-Refresh mode (MR2 A6 = 1b and MR2 A7 = 0b). Please refer to the supplier data sheet and/or the DIMM SPD for Auto Self-Refresh option availability, Extended Temperature Range support and tREFI requirements in the Extended Temperature Range.

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DC Electrical Characteristics and Operating Conditions

Symbol	Parameter	Min	Type	Max	Units	Notes
VDD	Supply Voltage	1.425	1.5	1.575	V	1,2
VDDQ	Output Supply Voltage	1.425	1.5	1.575	V	1,2
VDD	Supply Voltage	1.25	1.35	1.4175	V	DDR3L
VDDQ	Output Supply Voltage	1.25	1.35	1.4175	V	DDR3L

Note:

- Under all conditions VDDQ must be less than or equal to VDD.
- VDDQ tracks with VDD. AC parameters are measured with VDD and VDDQ tied together.

Single-Ended AC and DC Input Levels for Command and Address

Symbol	Parameter	DDR3-1066 (-BE)		DDR3-1333 (-CG)		Units	Note
		Min.	Max.	Min.	Max.		
VIH.CA(DC)	DC Input Logic High	Vref + 0.100	VDD	Vref + 0.100	VDD	V	1
VIL.CA(DC)	DC Input Logic Low	VSS	Vref - 0.100	VSS	Vref - 0.100	V	1
VIH.CA(AC)	AC Input Logic High	Vref + 0.175	Note 2	Vref + 0.175	Note 2	V	1, 2
VIL.CA(AC)	AC Input Logic Low	Note 2	Vref - 0.175	Note 2	Vref - 0.175	V	1, 2
VIH.CA(AC150)	AC Input Logic High	-	-	Vref + 0.15	Note 2	V	1, 2
VIL.CA(AC150)	AC Input Logic Low	-	-	Note 2	Vref - 0.15	V	1, 2
V _{RefCA(DC)}	Reference Voltage for ADD, CMD Inputs	0.49 x VDD	0.51 x VDD	0.49 x VDD	0.51 x VDD	V	3, 4

Note:

- For input only pins except RESET#. Vref = VrefCA(DC).
- See "Overshoot and Undershoot Specifications" in the device datasheet.
- The ac peak noise on VRef may not allow VRef to deviate from VRefDQ(DC) by more than +/-1% VDD (for reference: approx. +/- 15 mV).
- For reference: approx. VDD/2 +/- 15 mV.

Single-Ended AC and DC Input Levels for DQ and DM

Symbol	Parameter	DDR3-1066 (-BE)		DDR3-1333 (-CG)		Units	Note
		Min.	Max.	Min.	Max.		
VIH.DQ(DC)	DC Input Logic High	Vref + 0.100	VDD	Vref + 0.100	VDD	V	1
VIL.DQ(DC)	DC Input Logic Low	VSS	Vref - 0.100	VSS	Vref - 0.100	V	1
VIH.DQ(AC)	AC Input Logic High	Vref + 0.175	Note 2	Vref + 0.15	Note 2	V	1, 2, 5
VIL.DQ(AC)	AC Input Logic Low	Note 2	Vref - 0.175	Note 2	Vref - 0.15	V	1, 2, 5
V _{RefDQ(DC)}	Reference Voltage for DQ, DM Inputs	0.49 x VDD	0.51 x VDD	0.49 x VDD	0.51 x VDD	V	3, 4

Note:

- For input only pins except RESET#. Vref = VrefDQ(DC).
- See "Overshoot and Undershoot Specifications" in the device datasheet.
- The ac peak noise on VRef may not allow VRef to deviate from VRefDQ(DC) by more than +/-1% VDD (for reference: approx. +/- 15 mV).
- For reference: approx. VDD/2 +/- 15 mV.
- Single-ended swing requirement for DQS, DQS# is 350 mV (peak to peak). Differential swing requirement for DQS - DQS# is 700 mV (peak to peak).

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Operating, Standby, and Refresh Currents

$T_{CASE} = 0^{\circ}\text{C} \sim 85^{\circ}\text{C}$; $V_{DDQ} = V_{DD} = 1.5\text{V} \pm 0.075\text{V}$ [2GB – 1 Rank, 256Mx8 DDR3 SDRAMs]

Symbol	Parameter/Condition	PC3-8500 (-BE)	PC3-10600 (-CG)	Unit
IDD0	Operating One Bank Active-Precharge Current	649	697	mA
IDD1	Operating One Bank Active-Read-Precharge Current	816	879	mA
IDD2P0	Precharge Power-Down Current Slow Exit	37	40	mA
IDD2P1	Precharge Power-Down Current Fast Exit	117	135	mA
IDD2Q	Precharge Quiet Standby Current	187	214	mA
IDD2N	Precharge Standby Current	205	238	mA
IDD3P	Active Power-Down Current	128	145	mA
IDD3N	Active Standby Current	265	265	mA
IDD4R	Operating Burst Read Current	1137	1370	mA
IDD4W	Operating Burst Write Current	1156	1378	mA
IDD5B	Burst Refresh Current	1723	1733	mA
IDD6	Self Refresh Current: Normal Temperature Range	94	94	mA
IDD7	Operating Bank Interleave Read Current	2914	3552	mA

$T_{CASE} = 0^{\circ}\text{C} \sim 85^{\circ}\text{C}$; $V_{DDQ} = V_{DD} = 1.35\text{V} + 0.0675/-0.1\text{V}$ [2GB – 1 Rank, 256Mx8 DDR3 SDRAMs]

Symbol	Parameter/Condition	PC3-8500 (-BE)	PC3-10600 (-CG)	Unit
IDD0	Operating One Bank Active-Precharge Current	634	673	mA
IDD1	Operating One Bank Active-Read-Precharge Current	780	836	mA
IDD2P0	Precharge Power-Down Current Slow Exit	33	36	mA
IDD2P1	Precharge Power-Down Current Fast Exit	103	117	mA
IDD2Q	Precharge Quiet Standby Current	157	177	mA
IDD2N	Precharge Standby Current	172	193	mA
IDD3P	Active Power-Down Current	111	125	mA
IDD3N	Active Standby Current	228	228	mA
IDD4R	Operating Burst Read Current	1119	1346	mA
IDD4W	Operating Burst Write Current	1139	1356	mA
IDD5B	Burst Refresh Current	1663	1673	mA
IDD6	Self Refresh Current: Normal Temperature Range	74	74	mA
IDD7	Operating Bank Interleave Read Current	2822	3406	mA

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$T_{CASE} = 0^{\circ}\text{C} \sim 85^{\circ}\text{C}$; $V_{DDQ} = V_{DD} = 1.5\text{V} \pm 0.075\text{V}$ [4GB – 2 Ranks, 256Mx8 DDR3 SDRAMs]

Symbol	Parameter/Condition	PC3-8500 (-BE)	PC3-10600 (-CG)	Unit
IDD0	Operating One Bank Active-Precharge Current	915	962	mA
IDD1	Operating One Bank Active-Read-Precharge Current	1081	1144	mA
IDD2P0	Precharge Power-Down Current Slow Exit	74	79	mA
IDD2P1	Precharge Power-Down Current Fast Exit	235	269	mA
IDD2Q	Precharge Quiet Standby Current	375	428	mA
IDD2N	Precharge Standby Current	409	475	mA
IDD3P	Active Power-Down Current	256	290	mA
IDD3N	Active Standby Current	531	531	mA
IDD4R	Operating Burst Read Current	1402	1635	mA
IDD4W	Operating Burst Write Current	1422	1643	mA
IDD5B	Burst Refresh Current	1988	1998	mA
IDD6	Self Refresh Current: Normal Temperature Range	187	187	mA
IDD7	Operating Bank Interleave Read Current	3179	3817	mA

$T_{CASE} = 0^{\circ}\text{C} \sim 85^{\circ}\text{C}$; $V_{DDQ} = V_{DD} = 1.35\text{V} + 0.0675\text{V} / -0.1\text{V}$ [4GB – 2 Ranks, 256Mx8 DDR3 SDRAMs]

Symbol	Parameter/Condition	PC3-8500 (-BE)	PC3-10600 (-CG)	Unit
IDD0	Operating One Bank Active-Precharge Current	863	902	mA
IDD1	Operating One Bank Active-Read-Precharge Current	1010	1064	mA
IDD2P0	Precharge Power-Down Current Slow Exit	66	71	mA
IDD2P1	Precharge Power-Down Current Fast Exit	206	235	mA
IDD2Q	Precharge Quiet Standby Current	314	354	mA
IDD2N	Precharge Standby Current	343	385	mA
IDD3P	Active Power-Down Current	222	251	mA
IDD3N	Active Standby Current	457	457	mA
IDD4R	Operating Burst Read Current	1348	1575	mA
IDD4W	Operating Burst Write Current	1368	1585	mA
IDD5B	Burst Refresh Current	1893	1901	mA
IDD6	Self Refresh Current: Normal Temperature Range	148	148	mA
IDD7	Operating Bank Interleave Read Current	3051	3634	mA

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Standard Speed Bins

DDR3-1066MHz

Speed Bin		DDR3-1066				Unit	
CL-nRCD-nRP		7-7-7 (-BE)		8-8-8 (-BF)			
Parameter	Symbol	Min	Max	Min	Max.		
Internal read command to first data	tAA	13.125	20.000	15.000	20.000	ns	
ACT to internal read or write delay time	tRCD	13.125	-	15.000	-	ns	
PRE command period	tRP	13.125	-	15.000	-	ns	
ACT to ACT or REF command period	tRC	50.625	-	52.500	-	ns	
ACT to PRE command period	tRAS	37.500	9*tREFI	37.500	9*tREFI	ns	
CL=5	CWL=5	tCK(AVG)	3.000	3.300	3.000	3.300	
	CWL=6	tCK(AVG)	Reserved	Reserved	Reserved	ns	
CL=6	CWL=5	tCK(AVG)	2.500	3.300	2.500	3.300	
	CWL=6	tCK(AVG)	Reserved	Reserved	Reserved	ns	
CL=7	CWL=5	tCK(AVG)	Reserved	Reserved	Reserved	ns	
	CWL=6	tCK(AVG)	1.875	<2.5	Reserved	ns	
CL=8	CWL=5	tCK(AVG)	Reserved	Reserved	Reserved	ns	
	CWL=6	tCK(AVG)	1.875	<2.5	1.875	<2.5	
Supported CL Settings		6,7,8		6,8		nCK	
Supported CWL Settings		5,6		5,6		nCK	

DDR3-1333MHz

Speed Bin		DDR3-1333				Unit	
CL-nRCD-nRP		8-8-8 (-CF)		9-9-9 (-CG)			
Parameter	Symbol	Min	Max	Min	Max		
Internal read command to first data	tAA	12.000	20.000	13.125	20.000	ns	
ACT to internal read or write delay time	tRCD	12.000	-	13.125	-	ns	
PRE command period	tRP	12.000	-	13.125	-	ns	
ACT to ACT or REF command period	tRC	48.000	-	49.125	-	ns	
ACT to PRE command period	tRAS	36.000	9*tREFI	36.000	9*tREFI	ns	
CL=5	CWL=5	tCK(AVG)	2.500	3.300	Reserved	Reserved	
	CWL=6	tCK(AVG)	Reserved	Reserved	Reserved	Reserved	
	CWL=7	tCK(AVG)	Reserved	Reserved	Reserved	Reserved	
CL=6	CWL=5	tCK(AVG)	2.500	3.300	2.500	3.300	
	CWL=6	tCK(AVG)	Reserved	Reserved	Reserved	Reserved	
	CWL=7	tCK(AVG)	Reserved	Reserved	Reserved	Reserved	
CL=7	CWL=5	tCK(AVG)	Reserved	Reserved	Reserved	Reserved	
	CWL=6	tCK(AVG)	1.875	<2.5	1.875*	<2.5*	
	CWL=7	tCK(AVG)	Reserved	Reserved	Reserved	Reserved	
CL=8	CWL=5	tCK(AVG)	Reserved	Reserved	Reserved	Reserved	
	CWL=6	tCK(AVG)	1.875	<2.5	1.875	<2.5	
	CWL=7	tCK(AVG)	1.500	<1.875	Reserved	Reserved	
CL=9	CWL=5	tCK(AVG)	Reserved	Reserved	Reserved	Reserved	
	CWL=6	tCK(AVG)	Reserved	Reserved	Reserved	Reserved	
	CWL=7	tCK(AVG)	1.500	<1.875	1.500	<1.875	
CL=10	CWL=5	tCK(AVG)	Reserved	Reserved	Reserved	Reserved	
	CWL=6	tCK(AVG)	Reserved	Reserved	Reserved	Reserved	
	CWL=7	tCK(AVG)	1.500*	<1.875*	1.500*	<1.875*	
Supported CL Settings		5,6,7,8,9		6,7,8,9		nCK	
Supported CWL Settings		5,6,7		5,6,7		nCK	

*: Optional

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AC Timing Specifications for DDR3 SDRAM Devices Used on Module (1066MHz)

Parameter	Symbol	DDR3-1066		Units	Notes
		Min.	Max.		
Clock Timing					
Minimum Clock Cycle Time (DLL off mode)	tCK (DLL_OFF)	8	-	ns	
Average Clock Period	tCK(avg)	Refer to "Standard Speed Bins"		ps	
Average high pulse width	tCH(avg)	0.47	0.53	tCK(avg)	
Average low pulse width	tCL(avg)	0.47	0.53	tCK(avg)	
Absolute Clock Period	tCK(abs)	Min.: tCK(avg)min + tJIT(per)min Max.: tCK(avg)max + tJIT(per)max		ps	
Absolute clock HIGH pulse width	tCH(abs)	0.43	-	tCK(avg)	
Absolute clock LOW pulse width	tCL(abs)	0.43	-	tCK(avg)	
Clock Period Jitter	tJIT(per)	-90	90	ps	
Clock Period Jitter during DLL locking period	tJIT(cc, lck)	-80	80	ps	
Cycle to Cycle Period Jitter	tJIT(cc)	180	180	ps	
Cycle to Cycle Period Jitter during DLL locking period	tJIT(cc, lck)	160	160	ps	
Duty Cycle Jitter	tJIT(duty)	-	-	ps	
Cumulative error across 2 cycles	tERR(2per)	-132	132	ps	
Cumulative error across 3 cycles	tERR(3per)	-157	157	ps	
Cumulative error across 4 cycles	tERR(4per)	-175	175	ps	
Cumulative error across 5 cycles	tERR(5per)	-188	188	ps	
Cumulative error across 6 cycles	tERR(6per)	-200	200	ps	
Cumulative error across 7 cycles	tERR(7per)	-209	209	ps	
Cumulative error across 8 cycles	tERR(8per)	-217	217	ps	
Cumulative error across 9 cycles	tERR(9per)	-224	224	ps	
Cumulative error across 10 cycles	tERR(10per)	-231	231	ps	
Cumulative error across 11 cycles	tERR(11per)	-237	237	ps	
Cumulative error across 12 cycles	tERR(12per)	-242	242	ps	
Cumulative error across n = 13, 14 . . . 49, 50 cycles	tERR(nper)	tERR(nper)min = (1 + 0.68ln(n)) * tJIT(per)min tERR(nper)max = (1 + 0.68ln(n)) * tJIT(per)max		ps	
Data Timing					
DQS, DQS# to DQ skew, per group, per access	tDQSQ	-	150	ps	
DQ output hold time from DQS, DQS#	tQH	0.38	-	tCK(avg)	
DQ low-impedance time from CK, CK#	tLZ(DQ)	-600	300	ps	
DQ high impedance time from CK, CK#	tHZ(DQ)	-	300	ps	
Data setup time to DQS, DQS# referenced to Vih(ac) / Vil(ac) levels	tDS(base) AC175	25		ps	
Data setup time to DQS, DQS# referenced to Vih(ac) / Vil(ac) levels	tDS(base) AC150	75		ps	
Data hold time from DQS, DQS# referenced to Vih(dc) / Vil(dc) levels	tDH(base) DC100	100		ps	
DQ and DM Input pulse width for each input	tDIPW	490		ps	
Data Strobe Timing					
DQS,DQS# differential READ Preamble	tRPRE	0.9	Note 19	tCK(avg)	
DQS, DQS# differential READ Postamble	tRPST	0.3	Note 11	tCK(avg)	
DQS, DQS# differential output high time	tQSH	0.38	-	tCK(avg)	
DQS, DQS# differential output low time	tQL	0.38	-	tCK(avg)	
DQS, DQS# differential WRITE Preamble	tWPRE	0.9	-	tCK(avg)	
DQS, DQS# differential WRITE Postamble	tWPST	0.3	-	tCK(avg)	
DQS, DQS# rising edge output access time from rising CK, CK#	tDQSCK	-300	300	tCK(avg)	
DQS and DQS# low-impedance time (Referenced from RL - 1)	tLZ(DQS)	-600	300	tCK(avg)	
DQS and DQS# high-impedance time (Referenced from RL + BL/2)	tHZ(DQS)	-	300	tCK(avg)	
DQS, DQS# differential input low pulse width	tDQSL	0.45	0.55	tCK(avg)	
DQS, DQS# differential input high pulse width	tDQSH	0.45	0.55	tCK(avg)	
DQS, DQS# rising edge to CK, CK# rising edge	tDQSS	-0.25	0.25	tCK(avg)	
DQS, DQS# falling edge setup time to CK, CK# rising edge	tDSS	0.2	-	tCK(avg)	
DQS, DQS# falling edge hold time from CK, CK# rising edge	tDSH	0.2	-	tCK(avg)	
Command and Address Timing					

**NT2GC72B89B0NF / NT4GC72B8PB0NF
 NT2GC72C89B0NF / NT4GC72C8PB0NF
 2GB: 256M x 72 / 4GB: 512M x 72
 PC3-8500 / PC3-10600
 Unbuffered DDR3 SDRAM DIMM with ECC**



DLL locking time	tDLLK	512	-	nCK	
Internal READ Command to PRECHARGE Command delay	tRTP	tRTPmin.: max(4nCK, 7.5ns) tRTPmax.: -			
Delay from start of internal write transaction to internal read command	tWTR	tWTRmin.: max(4nCK, 7.5ns) tWTRmax.: -			
WRITE recovery time	tWR	15	-	ns	
Mode Register Set command cycle time	tMRD	4	-	nCK	
Mode Register Set command update delay	tMOD	tMODmin.: max(12nCK, 15ns) tMODmax.: -			
ACT to internal read or write delay time	tRCD				
PRE command period	tRP				
ACT to ACT or REF command period	tRC				
CAS# to CAS# command delay	tCCD	4	-	nCK	
Auto precharge write recovery + precharge time	tDAL(min)	WR + roundup(tRP / tCK(avg))		nCK	
Multi-Purpose Register Recovery Time	tMPRR	1	-	nCK	
ACTIVE to PRECHARGE command period	tRAS	Standard Speed Bins			
ACTIVE to ACTIVE command period for 1KB page size	tRRD	max(4nCK, 7.5ns)	-		
ACTIVE to ACTIVE command period for 2KB page size	tRRD	tRRDmin.: max(4nCK, 10ns) tRRDmax.: -			
Four activate window for 1KB page size	tFAW	37.5	-	ns	
Four activate window for 2KB page size	tFAW	50	-	ns	
Command and Address setup time to CK, CK# referenced to Vih(ac) / Vil(ac) levels	tIS(base)	125	-	ps	
Command and Address hold time from CK, CK# referenced to Vih(dc) / Vil(dc) levels	tIH(base)	200	-	ps	
Command and Address setup time to CK, CK# referenced to Vih(ac) / Vil(ac) levels	tIS(base) AC150	125+150	-	ps	
Control and Address Input pulse width for each input	tIPW	780	-	ps	
Calibration Timing					
Power-up and RESET calibration time	tZQinit	512	-	nCK	
Normal operation Full calibration time	tZQoper	256	-	nCK	
Normal operation Short calibration time	tZQCS	64	-	nCK	
Reset Timing					
Exit Reset from CKE HIGH to a valid command	tXPR	tXPRmin.: max(5nCK, tRFC(min) + 10ns) tXPRmax.: -			
Self Refresh Timings					
Exit Self Refresh to commands not requiring a locked DLL	tXS	tXSmin.: max(5nCK, tRFC(min) + 10ns) tXSmax.: -			
Exit Self Refresh to commands requiring a locked DLL	tXSDLL	tXSDLLmin.: tDLL(min) tXSDLLmax.: -		nCK	
Minimum CKE low width for Self Refresh entry to exit timing	tCKESR	tCKESRmin.: tCKE(min) + 1 nCK tCKESRmax.: -			
Valid Clock Requirement after Self Refresh Entry (SRE) or Power-Down Entry (PDE)	tCKSRE	tCKSREmin.: max(5 nCK, 10 ns) tCKSREmax.: -			
Valid Clock Requirement before Self Refresh Exit (SRX) or Power-Down Exit (PDX) or Reset Exit	tCKSRX	tCKSRXmin.: max(5 nCK, 10 ns) tCKSRXmax.: -			
Power Down Timings					
Exit Power Down with DLL on to any valid command; Exit Precharge Power Down with DLL frozen to commands not requiring a locked DLL	tXP	tXPmin.: max(3nCK, 7.5ns) tXPmax.: -			
Exit Precharge Power Down with DLL frozen to commands requiring a locked DLL	tXPDLL	tXPDLLmin.: max(10nCK, 24ns) tXPDLLmax.: -			
CKE minimum pulse width	tCKE	tCKEmin.: max(3nCK 5.625ns) tCKEmax.: -			
Command pass disable delay	tCPDED	tCPDEDmin.: 1 tCPDEDmax.: -		nCK	
Power Down Entry to Exit Timing	tPD	tPDmin.: tCKE(min) tPDmax.: 9*tREFI			
Timing of ACT command to Power Down entry	tACTPDEN	tACTPDENmin.: 1 tACTPDENmax.: -		nCK	
Timing of PRE or PREA command to Power Down entry	tPRPDEN	tPRPDENmin.: 1		nCK	

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		tPRPDENmax.: -		
Timing of RD/RDA command to Power Down entry	tRDPDEN	tRDPDENmin.: RL+4+1 tRDPDENmax.: -	nCK	
Timing of WR command to Power Down entry (BL8OTF, BL8MRS, BC4OTF)	tWRPDEN	tWRPDENmin.: WL + 4 + (tWR / tCK(avg)) tWRPDENmax.: -	nCK	
Timing of WRA command to Power Down entry (BL8OTF, BL8MRS, BC4OTF)	tWRAPDEN	tWRAPDENmin.: WL+4+WR+1 tWRAPDENmax.: -	nCK	
Timing of WR command to Power Down entry (BC4MRS)	tWRPDEN	tWRPDENmin.: WL + 2 + (tWR / tCK(avg)) tWRPDENmax.: -	nCK	
Timing of WRA command to Power Down entry (BC4MRS)	tWRAPDEN	tWRAPDENmin.: WL + 2 +WR + 1 tWRAPDENmax.: -	nCK	
Timing of REF command to Power Down entry	tREFPDEN	tREFPDENmin.: 1 tREFPDENmax.: -	nCK	
Timing of MRS command to Power Down entry	tMRSPDEN	tMRSPDENmin.: tMOD(min) tMRSPDENmax.: -		
ODT Timings				
ODT high time without write command or with write command and BC4	ODTH4	ODTH4min.: 4 ODTH4max.: -	nCK	
ODT high time with Write command and BL8	ODTH8	ODTH8min.: 6 ODTH8max.: -	nCK	
Asynchronous RTT turn-on delay (Power-Down with DLL frozen)	tAONPD	2	8.5	ns
Asynchronous RTT turn-off delay (Power-Down with DLL frozen)	tAOFPD	2	8.5	ns
RTT turn-on	tAON	-300	300	ps
RTT_Nom and RTT_WR turn-off time from ODTloff reference	tAOF	0.3	0.7	tCK(avg)
RTT dynamic change skew	tADC	0.3	0.7	tCK(avg)
Write Leveling Timings				
First DQS/DQS# rising edge after write leveling mode is programmed	tWLMD	40	-	nCK
DQS/DQS# delay after write leveling mode is programmed	tWLDQSEN	25	-	nCK
Write leveling setup time from rising CK, CK# crossing to rising DQS, DQS# crossing	tWLS	245	-	ps
Write leveling hold time from rising DQS, DQS# crossing to rising CK, CK# crossing	tWLH	245	-	ps
Write leveling output delay	tWLO	0	9	ns
Write leveling output error	tWLOE	0	2	ns

AC Timing Specifications for DDR3 SDRAM Devices Used on Module (1333MHz)

Parameter	Symbol	DDR3-1333		Units	Notes
		Min.	Max.		
Clock Timing					
Minimum Clock Cycle Time (DLL off mode)	tCK (DLL_OFF)	8	-	ns	
Average Clock Period	tCK(avg)	Refer to "Standard Speed Bins"		ps	
Average high pulse width	tCH(avg)	0.47	0.53	tCK(avg)	
Average low pulse width	tCL(avg)	0.47	0.53	tCK(avg)	
Absolute Clock Period	tCK(abs)	Min.: tCK(avg)min + tJIT(per)min Max.: tCK(avg)max + tJIT(per)max		ps	
Absolute clock HIGH pulse width	tCH(abs)	0.43	-	tCK(avg)	
Absolute clock LOW pulse width	tCL(abs)	0.43	-	tCK(avg)	
Clock Period Jitter	tJIT(per)	-80	80	ps	
Clock Period Jitter during DLL locking period	tJIT(cc, lck)	-70	70	ps	
Cycle to Cycle Period Jitter	tJIT(cc)	160	160	ps	
Cycle to Cycle Period Jitter during DLL locking period	tJIT(cc, lck)	140	140	ps	
Duty Cycle Jitter	tJIT(duty)	-	-	ps	
Cumulative error across 2 cycles	tERR(2per)	-118	118	ps	
Cumulative error across 3 cycles	tERR(3per)	-140	140	ps	
Cumulative error across 4 cycles	tERR(4per)	-155	155	ps	
Cumulative error across 5 cycles	tERR(5per)	-168	168	ps	
Cumulative error across 6 cycles	tERR(6per)	-177	177	ps	
Cumulative error across 7 cycles	tERR(7per)	-186	186	ps	
Cumulative error across 8 cycles	tERR(8per)	-193	193	ps	
Cumulative error across 9 cycles	tERR(9per)	-200	200	ps	
Cumulative error across 10 cycles	tERR(10per)	-205	205	ps	
Cumulative error across 11 cycles	tERR(11per)	-210	210	ps	
Cumulative error across 12 cycles	tERR(12per)	-215	215	ps	
Cumulative error across n = 13, 14 . . . 49, 50 cycles	tERR(nper)	tERR(nper)min = (1 + 0.68ln(n)) * tJIT(per)min tERR(nper)max = (1 + 0.68ln(n)) * tJIT(per)max		ps	
Data Timing					
DQS, DQS# to DQ skew, per group, per access	tDQSQ	-	125	ps	
DQ output hold time from DQS, DQS#	tQH	0.38	-	tCK(avg)	
DQ low-impedance time from CK, CK#	tLZ(DQ)	-500	250	ps	
DQ high impedance time from CK, CK#	tHZ(DQ)	-	250	ps	
Data setup time to DQS, DQS# referenced to Vih(ac) / Vil(ac) levels	tDS(base) AC175	-		ps	
Data setup time to DQS, DQS# referenced to Vih(ac) / Vil(ac) levels	tDS(base) AC150	30		ps	
Data hold time from DQS, DQS# referenced to Vih(dc) / Vil(dc) levels	tDH(base) DC100	65		ps	
DQ and DM Input pulse width for each input	tDIPW	400	-	ps	
Data Strobe Timing					
DQS,DQS# differential READ Preamble	tRPRE	0.9	Note 19	tCK(avg)	
DQS, DQS# differential READ Postamble	tRPST	0.3	Note 11	tCK(avg)	
DQS, DQS# differential output high time	tQSH	0.4	-	tCK(avg)	
DQS, DQS# differential output low time	tQL	0.4	-	tCK(avg)	
DQS, DQS# differential WRITE Preamble	tWPRE	0.9	-	tCK(avg)	
DQS, DQS# differential WRITE Postamble	tWPST	0.3	-	tCK(avg)	
DQS, DQS# rising edge output access time from rising CK, CK#	tDQSCK	-255	255	tCK(avg)	
DQS and DQS# low-impedance time (Referenced from RL - 1)	tLZ(DQS)	-500	250	tCK(avg)	
DQS and DQS# high-impedance time (Referenced from RL + BL/2)	tHZ(DQS)	-	250	tCK(avg)	
DQS, DQS# differential input low pulse width	tDQSL	0.45	0.55	tCK(avg)	
DQS, DQS# differential input high pulse width	tDQSH	0.45	0.55	tCK(avg)	
DQS, DQS# rising edge to CK, CK# rising edge	tDQSS	-0.25	0.25	tCK(avg)	
DQS, DQS# falling edge setup time to CK, CK# rising edge	tDSS	0.2	-	tCK(avg)	
DQS, DQS# falling edge hold time from CK, CK# rising edge	tDSH	0.2	-	tCK(avg)	
Command and Address Timing					

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DLL locking time	tDLLK	512	-	nCK	
Internal READ Command to PRECHARGE Command delay	tRTP	tRTPmin.: max(4nCK, 7.5ns) tRTPmax.: -			
Delay from start of internal write transaction to internal read command	tWTR	tWTRmin.: max(4nCK, 7.5ns) tWTRmax.: -			
WRITE recovery time	tWR	15	-	ns	
Mode Register Set command cycle time	tMRD	4	-	nCK	
Mode Register Set command update delay	tMOD	tMODmin.: max(12nCK, 15ns) tMODmax.: -			
ACT to internal read or write delay time	tRCD				
PRE command period	tRP				
ACT to ACT or REF command period	tRC				
CAS# to CAS# command delay	tCCD	4		nCK	
Auto precharge write recovery + precharge time	tDAL(min)	WR + roundup(tRTP / tCK(avg))		nCK	
Multi-Purpose Register Recovery Time	tMPRR	1	-	nCK	
ACTIVE to PRECHARGE command period	tRAS	Standard Speed Bins			
ACTIVE to ACTIVE command period for 1KB page size	tRRD	tRRDmin.: max(4nCK, 6ns) tRRDmax.: -			
ACTIVE to ACTIVE command period for 2KB page size	tRRD	tRRDmin.: max(4nCK, 7.5ns) tRRDmax.: -			
Four activate window for 1KB page size	tFAW	30	0	ns	
Four activate window for 2KB page size	tFAW	45	0	ns	
Command and Address setup time to CK, CK# referenced to Vih(ac) / Vil(ac) levels	tS(base)	65	-	ps	
Command and Address hold time from CK, CK# referenced to Vih(dc) / Vil(dc) levels	tH(base)	140	-	ps	
Command and Address setup time to CK, CK# referenced to Vih(ac) / Vil(ac) levels	tS(base) AC150	65+125	-	ps	
Control and Address Input pulse width for each input	tIPW	620	-	ps	
Calibration Timing					
Power-up and RESET calibration time	tZQinit	512	-	nCK	
Normal operation Full calibration time	tZQoper	256	-	nCK	
Normal operation Short calibration time	tZQCS	64	-	nCK	
Reset Timing					
Exit Reset from CKE HIGH to a valid command	tXPR	tXPRmin.: max(5nCK, tRFC(min) + 10ns) tXPRmax.: -			
Self Refresh Timings					
Exit Self Refresh to commands not requiring a locked DLL	tXS	tXSmin.: max(5nCK, tRFC(min) + 10ns) tXSmax.: -			
Exit Self Refresh to commands requiring a locked DLL	tXSDL	tXSDLmin.: tDLL(min) tXSDLmax.: -		nCK	
Minimum CKE low width for Self Refresh entry to exit timing	tCKESR	tCKESRmin.: tCKE(min) + 1 nCK tCKESRmax.: -			
Valid Clock Requirement after Self Refresh Entry (SRE) or Power-Down Entry (PDE)	tCKSRE	tCKSREmin.: max(5 nCK, 10 ns) tCKSREmax.: -			
Valid Clock Requirement before Self Refresh Exit (SRX) or Power-Down Exit (PDX) or Reset Exit	tCKSRX	tCKSRXmin.: max(5 nCK, 10 ns) tCKSRXmax.: -			
Power Down Timings					
Exit Power Down with DLL on to any valid command; Exit Precharge Power Down with DLL frozen to commands not requiring a locked DLL	tXP	tXPmin.: max(3nCK, 6ns) tXPmax.: -			
Exit Precharge Power Down with DLL frozen to commands requiring a locked DLL	tXPDLL	tXPDLLmin.: max(10nCK, 24ns) tXPDLLmax.: -			
CKE minimum pulse width	tCKE	tCKEmin.: max(3nCK, 5.625ns) tCKEmax.: -			
Command pass disable delay	tCPDED	tCPDEDmin.: 1 tCPDEDmax.: -		nCK	
Power Down Entry to Exit Timing	tPD	tPDmin.: tCKE(min) tPDmax.: 9*tREFI			
Timing of ACT command to Power Down entry	tACTPDEN	tACTPDENmin.: 1 tACTPDENmax.: -		nCK	

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 2GB: 256M x 72 / 4GB: 512M x 72
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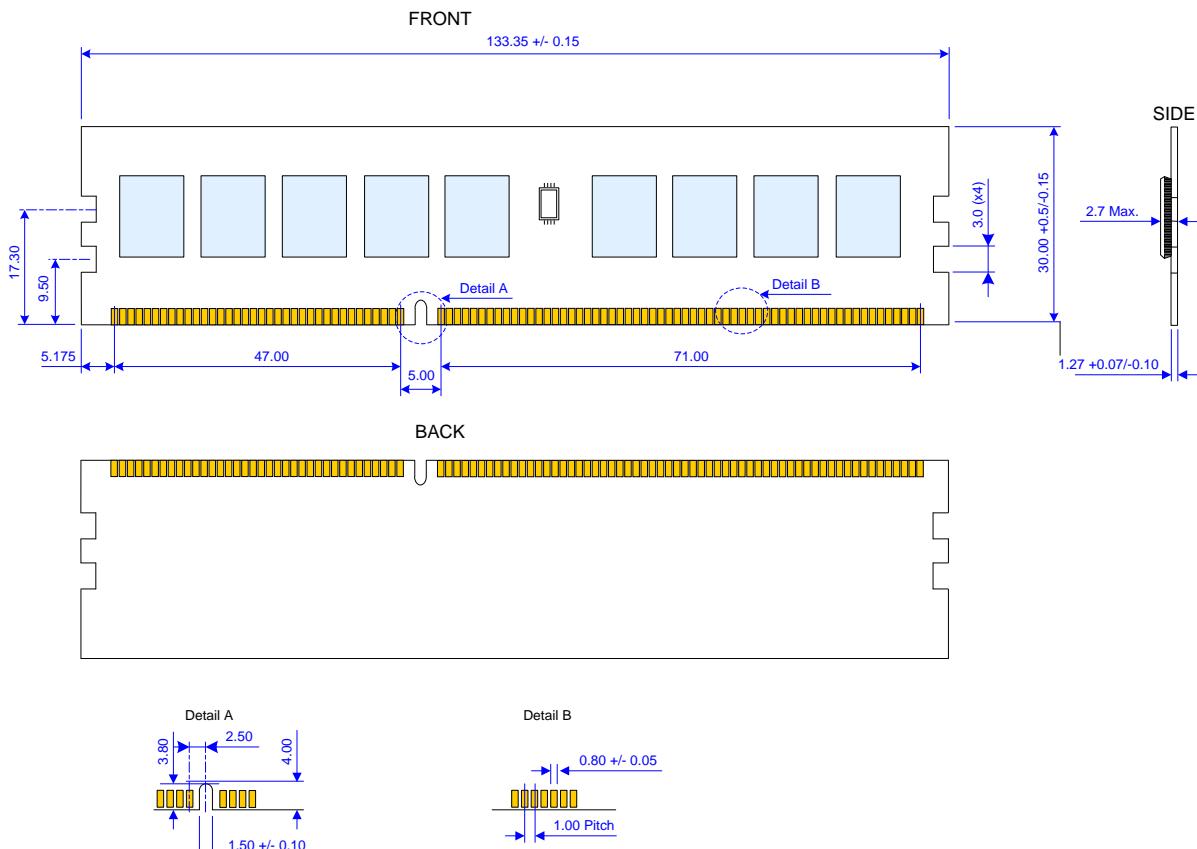
Timing of PRE or PREA command to Power Down entry	tPRPDEN	tPRPDENmin.: 1 tPRPDENmax.: -	nCK	
Timing of RD/RDA command to Power Down entry	tRDPDEN	tRDPDENmin.: RL+4+1 tRDPDENmax.: -	nCK	
Timing of WR command to Power Down entry (BL8OTF, BL8MRS, BC4OTF)	tWRPDEN	tWRPDENmin.: WL + 4 + (tWR / tCK(avg)) tWRPDENmax.: -	nCK	
Timing of WRA command to Power Down entry (BL8OTF, BL8MRS, BC4OTF)	tWRAPDEN	tWRAPDENmin.: WL+4+WR+1 tWRAPDENmax.: -	nCK	
Timing of WR command to Power Down entry (BC4MRS)	tWRPDEN	tWRPDENmin.: WL + 2 + (tWR / tCK(avg))tWRPDENmax.: -	nCK	
Timing of WRA command to Power Down entry (BC4MRS)	tWRAPDEN	tWRAPDENmin.: WL + 2 +WR + 1 tWRAPDENmax.: -	nCK	
Timing of REF command to Power Down entry	tREFPDEN	tREFPDENmin.: 1 tREFPDENmax.: -	nCK	
Timing of MRS command to Power Down entry	tMRSPDEN	tMRSPDENmin.: tMOD(min) tMRSPDENmax.: -		
ODT Timings				
ODT high time without write command or with write command and BC4	ODTH4	ODTH4min.: 4 ODTH4max.: -	nCK	
ODT high time with Write command and BL8	ODTH8	ODTH8min.: 6 ODTH8max.: -	nCK	
Asynchronous RTT turn-on delay (Power-Down with DLL frozen)	tAONPD	2	8.5	ns
Asynchronous RTT turn-off delay (Power-Down with DLL frozen)	tAOFPD	2	8.5	ns
RTT turn-on	tAON	-250	250	ps
RTT_Nom and RTT_WR turn-off time from ODTloff reference	tAOF	0.3	0.7	tCK(avg)
RTT dynamic change skew	tADC	0.3	0.7	tCK(avg)
Write Leveling Timings				
First DQS/DQS# rising edge after write leveling mode is programmed	tWLMD	40	-	nCK
DQS/DQS# delay after write leveling mode is programmed	tWLDQSEN	25	-	nCK
Write leveling setup time from rising CK, CK# crossing to rising DQS, DQS# crossing	tWLS	195	-	ps
Write leveling hold time from rising DQS, DQS# crossing to rising CK, CK# crossing	tWLH	195	-	ps
Write leveling output delay	tWLO	0	9	ns
Write leveling output error	tWLOE	0	2	ns

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PC3-8500 / PC3-10600
Unbuffered DDR3 SDRAM DIMM with ECC



Package Dimensions

[NT2GC72C89B0NF, 2GB – 1 Rank, 256Mx8 DDR3 SDRAMs]



Units: Millimeters

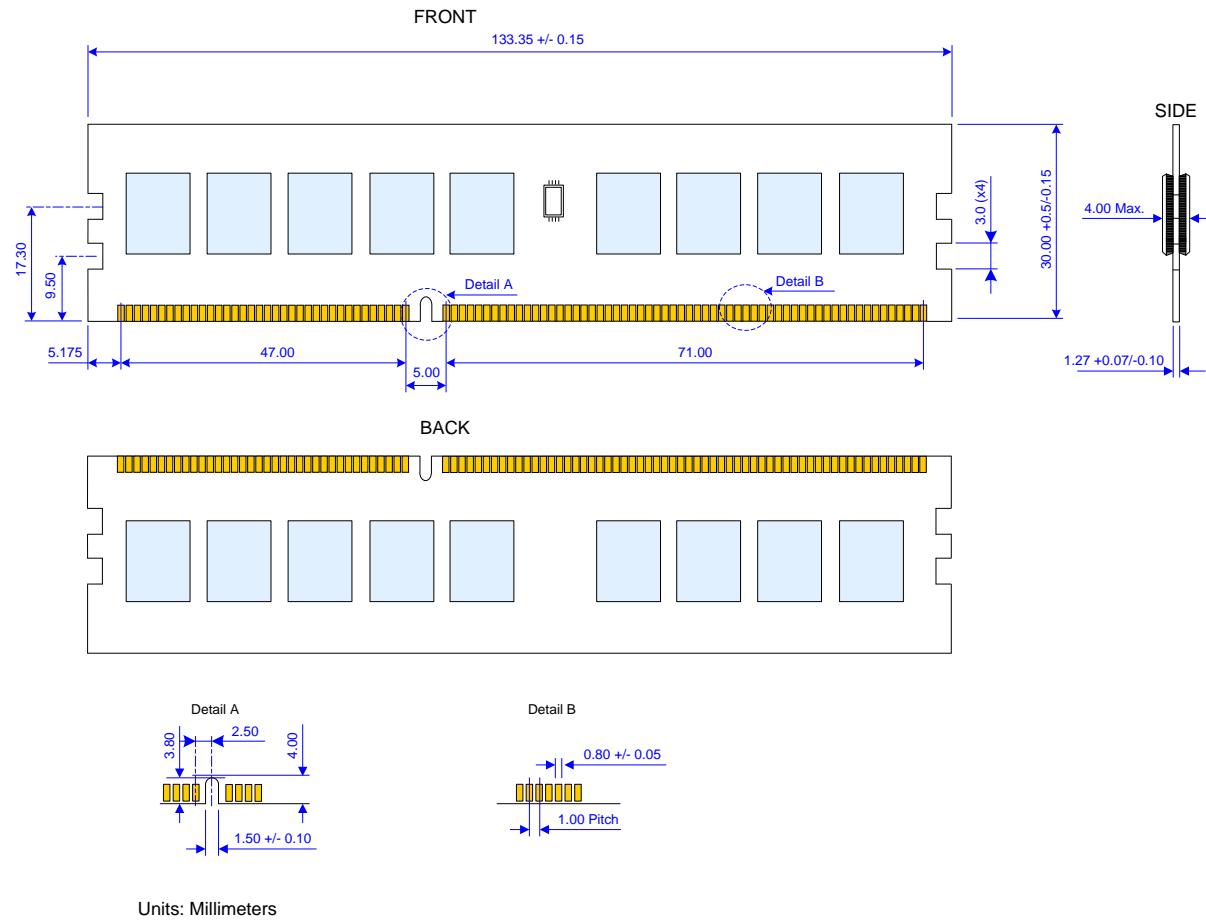
Note: Device position and scale are only for reference.

NT2GC72B89B0NF / NT4GC72B8PB0NF
NT2GC72C89B0NF / NT4GC72C8PB0NF
2GB: 256M x 72 / 4GB: 512M x 72
PC3-8500 / PC3-10600
Unbuffered DDR3 SDRAM DIMM with ECC



Package Dimensions

[NT4GC72C8PB0NF, 4GB – 2 Ranks, 256Mx8 DDR3 SDRAMs]



Note: Device position and scale are only for reference.

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2GB: 256M x 72 / 4GB: 512M x 72
PC3-8500 / PC3-10600
Unbuffered DDR3 SDRAM DIMM with ECC**



Revision Log

Rev	Date	Modification
0.1	02/2010	Preliminary Release
0.5	05/2010	Preliminary Release 2
1.0	05/2010	Official Release

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